| , (| Application No. | Applicant(s) |
|--|---|---|
| · | | Applicatings |
| Notice of Allowability | 10/623,786 | NAKAJIMA ET AL. |
| | Examiner | Art Unit |
| | Gwendolyn A. Blackwell-Rud | asill 1775 |
| The MAILING DATE of this communication Il claims being allowable, PROSECUTION ON THE MERerewith (or previously mailed), a Notice of Allowance (PTOTICE OF ALLOWABILITY IS NOT A GRANT OF PATIFIED for the Office or upon petition by the applicant. See 37 CFF | ITS IS (OR REMAINS) CLOSED in the OL-85) or other appropriate communice of RIGHTS. This application is sub- | nis application. If not included cation will be mailed in due course. THIS |
| $\[igotimes$ This communication is responsive to $\underline{\it 28~May~2004}$. | | |
| . The allowed claim(s) is/are <u>5-7</u> . | | |
| . ☑ The drawings filed on <u>21 July 2003</u> are accepted by | the Examiner. | |
| a) Acknowledgment is made of a claim for foreign price a) All b) □ Some* c) □ None of the: | | (f). |
| 2. Certified copies of the priority document | ts have been received in Application I | No. <u>09/966,215</u> . |
| Copies of the certified copies of the prior | rity documents have been received in | this national stage application from the |
| International Bureau (PCT Rule 17.2(a) |). | |
| * Certified copies not received: | | |
| Applicant has THREE MONTHS FROM THE "MAILING I noted below. Failure to timely comply will result in ABAN THIS THREE-MONTH PERIOD IS NOT EXTENDABLE. | | reply complying with the requirements |
| . A SUBSTITUTE OATH OR DECLARATION must be INFORMAL PATENT APPLICATION (PTO-152) whi | | |
| . CORRECTED DRAWINGS (as "replacement sheets | s") must be submitted. | |
| (a) ☐ including changes required by the Notice of Dra | ftsperson's Patent Drawing Review (| PTO-948) attached |
| 1) \square hereto or 2) \square to Paper No./Mail Date | | |
| (b) ☐ including changes required by the attached Exa Paper No./Mail Date | miner's Amendment / Comment or in | the Office action of |
| Identifying indicia such as the application number (see 37 each sheet. Replacement sheet(s) should be labeled as su | | |
| 7. DEPOSIT OF and/or INFORMATION about the attached Examiner's comment regarding REQUIREN | | |
| uttachment(s) | C Nation of later | and Detect Application (DTO 450) |
| ☐ Notice of References Cited (PTO-892)☐ Notice of Draftperson's Patent Drawing Review (PTO | | mal Patent Application (PTO-152) |
| | Paper No./Ma | nil Date |
| ☐ Information Disclosure Statements (PTO-1449 or PTO Paper No./Mail Date | O/SB/08), 7. ⊠ Examiner's An | nendment/Comment |
| Examiner's Comment Regarding Requirement for De | posit 8. ⊠ Examiner's Sta | atement of Reasons for Allowance |
| of Biological Material | 9. 🗌 Other | |
| | | Stepha Sterin |
| · | | STEPHEŃ STEIN |
| | | PRIMARY EXAMINER |

DETAILED ACTION

Specification

1. The abstract of the disclosure is objected to because the length of the abstract is too long. The abstract has been amended by Examiner's Amendment as set forth below to meet the length requirements of the abstract. *MPEP608.01(b)*.

EXAMINER'S AMENDMENT

- 2. An examiner's amendment to the record appears below. Should the changes and/or additions be unacceptable to applicant, an amendment may be filed as provided by 37 CFR 1.312. To ensure consideration of such an amendment, it MUST be submitted no later than the payment of the issue fee.
- 3. The application has been amended as follows:
- 4. In the specification, line 1, after the title insert --This application is a division of U.S. Serial No. 09/966,215 filed September 28, 2001, abandoned.--
- 5. Delete the abstract and insert A silica layer is provided which is usable as a low refractive index layer undergoing no change in its refractive index. Further, a silica layer is provided which is highly productive and usable as a medium or high refractive index layer undergoing neither reduction in transmittance nor change in spectral colors. Still further, an antireflection film using these silica layers is provided.--

Allowable Subject Matter

6. Claims 5-7 are allowed over the prior art of record.

7. The following is an examiner's statement of reasons for allowance:

The prior art while teaching that SiO_xC_y can be used as a layer on a substrate as an antireflective film having a refractive index as exemplified by Applicant, it does not teach or suggest the compositional limitations of the $SiO_{x/a/d}C_{y/b/e}$ in relation to the x/a/d and y/b/e subscripts for the oxygen and carbon components, respectively, of the silicon oxynitride film in conjunction with a particular refractive index. The prior art of record also does not teach or suggest the silicon oxynitride layer structure as claimed by Applicant.

Any comments considered necessary by applicant must be submitted no later than the payment of the issue fee and, to avoid processing delays, should preferably accompany the issue fee. Such submissions should be clearly labeled "Comments on Statement of Reasons for Allowance."

Conclusion

Any inquiry concerning this communication or earlier communications from the examiner should be directed to Gwendolyn A. Blackwell-Rudasill whose telephone number is (571) 272-1533. The examiner can normally be reached on Monday - Thursday; 6:00 am - 4:30 pm.

If attempts to reach the examiner by telephone are unsuccessful, the examiner's supervisor, Deborah Jones can be reached on (571) 272-1535. The fax phone number for the organization where this application or proceeding is assigned is 703-872-9306.

Art Unit: 1775

Information regarding the status of an application may be obtained from the Patent Application Information Retrieval (PAIR) system. Status information for published applications may be obtained from either Private PAIR or Public PAIR. Status information for unpublished applications is available through Private PAIR only. For more information about the PAIR system, see http://pair-direct.uspto.gov. Should you have questions on access to the Private PAIR system, contact the Electronic Business Center (EBC) at 866-217-9197 (toll-free).

Gwendolyn A. Blackwell-Rudasill Examiner Art Unit 1775

GEV.

STEPHEN STEIN PRIMARY EXAMINER

Steph Sten-